Inverter with Schmitt-Trigger

NL17SG14

The NL17SG14 is a single inverter with Schmitt−trigger input in tiny footprint packages. The device is designed to operate for V_{CC} = 0.9 V to 3.6 V.

Features

- Designed for 0.9 V to 3.6 V V_{CC} Operation
- 2.4 ns (Typ) at V_{CC} = 3.0 V, C_L = 15 pF
- Inputs/Outputs Over−Voltage Tolerant up to 3.6 V
- I_{OFF} Supports Partial Power Down Protection
- Available in UDFN Package
- −Q Suffix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC−Q100 Qualified and PPAP Capable
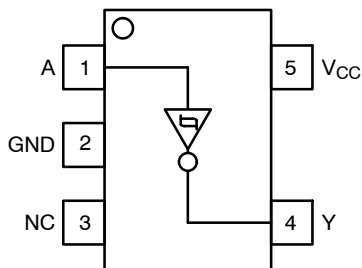- These Devices are Pb−Free, Halogen−Free/BFR−Free and RoHS−Compliant

MARKING DIAGRAMS

SOT−953
CASE 527AE

UDFN6
1.0 x 1.0
CASE 517BX

UDFN6
1.45 x 1.0
CASE 517AQ

SC−88A
DF SUFFIX
CASE 419A

M = Date Code*
▪ = Pb−Free Package

(Note: Microdot may be in either location)

*Date Code orientation and/or position may vary depending upon manufacturing location.
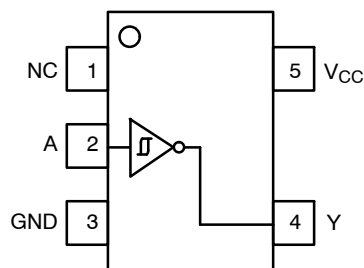

Figure 1. SOT−953
(Top Thru View)

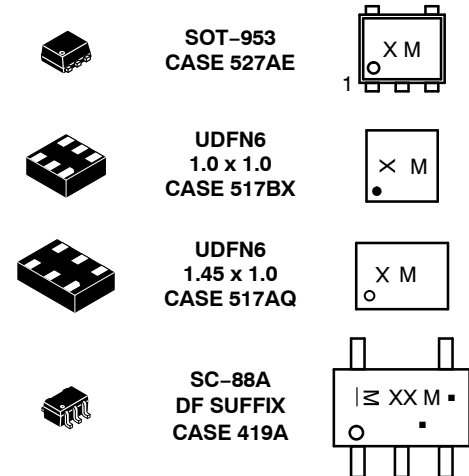
Figure 2. SC−88A
(Top View)
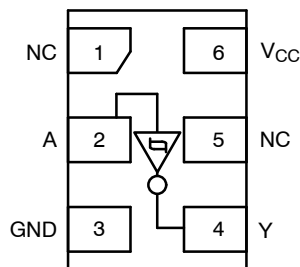
Figure 3. UDFN
(Top View)

Figure 4. Logic Symbol

PIN ASSIGNMENT

	SOT−953	SC−88A	UDFN6
1	A	NC	NC
2	GND	A	A
3	NC	GND	GND
4	Y	Y	Y
5	V_{CC}	V_{CC}	NC
6			V_{CC}

FUNCTION TABLE

A Input	Y Output
L	H
H	L

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 6 of this data sheet.

NOTE: Some of the devices on this data sheet have been **DISCONTINUED**. Please refer to the table on page 6.

NL17SG14

Table 1. MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V_{CC}	DC Supply Voltage	−0.5 to +4.3	V
V_{IN}	DC Input Voltage	−0.5 to +4.3	V
V_{OUT}	DC Output Voltage Active−Mode (High or Low State) Tri−State Mode (Note 1) Power−Down Mode (V_{CC} = 0 V)	−0.5 to V_{CC} + 0.5 −0.5 to +4.3 −0.5 to +4.3	V
I_{IK}	DC Input Diode Current V_{IN} < GND	−20	mA
I_{OK}	DC Output Diode Current V_{OUT} < GND	−20	mA
I_{OUT}	DC Output Source/Sink Current	±20	mA
$I_{CC\ or\ I_{GND}}$	DC Supply Current Per Supply Pin or Ground Pin	±20	mA
T_{STG}	Storage Temperature Range	−65 to +150	°C
T_L	Lead Temperature, 1 mm from Case for 10 Seconds	260	°C
T_J	Junction Temperature Under Bias	+150	°C
θ_{JA}	Thermal Resistance (Note 2)	154	°C/W
P_D	Power Dissipation in Still Air	812	mW
θ_{JA}	Thermal Resistance (Note 2) SC−88A SOT−953 UDFN6	377 254 154	°C/W
P_D	Power Dissipation in Still Air SC−88A SOT−953 UDFN6	332 491 812	mW
MSL	Moisture Sensitivity	Level 1	
F_R	Flammability Rating Oxygen Index: 28 to 34	UL 94 V−0 @ 0.125 in	
V_{ESD}	ESD Withstand Voltage (Note 3) Human Body Model Charged Device Model	2000 1000	V
$I_{LATCHUP}$	Latchup Performance (Note 4)	±100	mA

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
1. Applicable to devices with outputs that may be tri−stated.
2. Measured with minimum pad spacing on an FR4 board, using 10 mm − by − 1inch, 2 ounce copper trace no air flow per JESD51−7.
3. HBM tested to EIA / JESD22−A114−A. CDM tested to JESD22−C101−A. JEDEC recommends that ESD qualification to EIA/JESD22−A115A (Machine Model) be discontinued.
4. Tested to EIA/JESD78 Class II.

Table 2. RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Min	Max	Unit
V_{CC}	Positive DC Supply Voltage	0.9	3.6	V
V_{IN}	Digital Input Voltage	0	3.6	V
V_{OUT}	Output Voltage Active Mode (High or Low State) Tri−State Mode (Note 1) Power Down Mode (V_{CC} = 0 V)	0 0 0	V_{CC} 3.6 3.6	V
T_A	Operating Free−Air Temperature	−55	+125	°C
t_r, t_f	Input Transition Rise or Fall Rate	0	No Limit	nS/V

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

Table 3. DC ELECTRICAL CHARACTERISTICS

Symbol	Parameter	Conditions	V_{CC} (V)	$T_A = 25°C$			$T_A = -55°C$ to $+125°C$		Unit
				Min	Typ	Max	Min	Max	
V_{T+}	Positive Going Input Threshold Voltage		0.9	–	0.7	–	–	–	V
			1.1	–	0.81	0.95	–	0.95	
			1.4	–	0.94	1.16	–	1.16	
			1.65	–	1.06	1.3	–	1.3	
			2.3	–	1.36	1.73	–	1.73	
			3.0	–	1.8	2.24	–	2.24	
V_{T-}	Negative Going Input Threshold Voltage		0.9	–	0.23	–	–	–	V
			1.1	0.15	0.33	–	0.15	–	
			1.4	0.3	0.47	–	0.3	–	
			1.65	0.35	0.6	–	0.35	–	
			2.3	0.55	0.85	–	0.55	–	
			3.0	0.95	1.13	–	0.95	–	
V_H	Hysteresis Voltage		0.9	–	0.27	–	–	–	V
			1.1	0.2	0.35	0.8	0.2	0.8	
			1.4	0.25	0.41	0.86	0.25	0.86	
			1.65	0.30	0.46	0.9	0.30	0.9	
			2.3	0.40	0.56	1.05	0.40	1.05	
			3.0	0.49	0.59	1.1	0.49	1.1	
V_{OH}	High–Level Output Voltage	$V_{IN} = V_{IH}$ or V_{IL}							V
		$I_{OH} = -20 \mu A$	0.9	–	0.75	–	–	–	
		$I_{OH} = -0.3$ mA	1.1 o 1.3	$0.75 \times V_{CC}$	–	–	$0.75 \times V_{CC}$	–	
		$I_{OH} = -1.7$ mA	1.4 to 1.6	$0.75 \times V_{CC}$	–	–	$0.75 \times V_{CC}$	–	
		$I_{OH} = -3.0$ mA	1.65 to 1.95	$V_{CC} - 0.45$	–	–	$V_{CC} - 0.45$	–	
		$I_{OH} = -4.0$ mA	2.3 to 2.7	2.0	–	–	2.0	–	
		$I_{OH} = -8.0$ mA	3.0 to 3.6	2.48	–	–	2.48	–	
V_{OL}	Low–Level Output Voltage	$V_{IN} = V_{IH}$ or V_{IL}							V
		$I_{OL} = 20 \mu A$	0.9	–	0.1	–	–	–	
		$I_{OL} = 0.3$ mA	1.1 o 1.3	–	–	$0.25 \times V_{CC}$	–	$0.25 \times V_{CC}$	
		$I_{OL} = 1.7$ mA	1.4 to 1.6	–	–	$0.25 \times V_{CC}$	–	$0.25 \times V_{CC}$	
		$I_{OL} = 3.0$ mA	1.65 to 1.95	–	–	0.45	–	0.45	
		$I_{OL} = 4.0$ mA	2.3 to 2.7	–	–	0.4	–	0.4	
		$I_{OL} = 8.0$ mA	2.7 to 3.6	–	–	0.4	–	0.4	
I_{IN}	Input Leakage Current	$V_{IN} = 0$ V to 3.6 V	0.9 to 3.6	–	–	±0.1	–	±1.0	μA
I_{OFF}	Power Off Leakage Current	$V_{IN} = 0$ V to 3.6 V; $V_{OUT} = 0$ V to 3.6 V	0	–	–	1.0	–	10.0	μA
I_{CC}	Quiescent Supply Current	$V_{IN} = V_{CC}$ or GND	0.9 to 3.6	–	–	0.5	–	10.0	μA

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NL17SG14

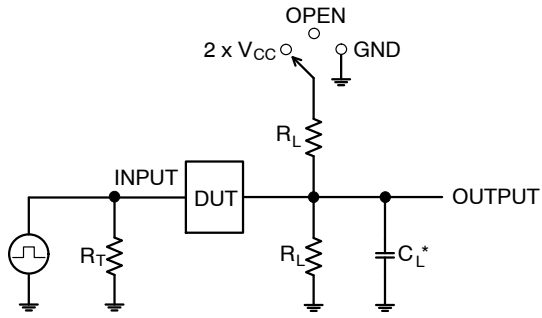**Table 4. AC ELECTRICAL CHARACTERISTICS**

Symbol	Parameter	Test Condition	V_{CC} (V)	T_A = 25°C			T_A = −55°C to +125°C		Unit
				Min	Typ	Max	Min	Max	
t_{PLH}, t_{PHL}	Propagation Delay, A to Y (Figures 5 and 6)	C_L = 10 pF, R_L = 1 MΩ	0.9	–	38.0	–	–	–	ns
			1.1 to 1.3	–	9.7	24.1	–	35.9	
			1.4 to 1.6	–	5.4	10.5	–	11.3	
			1.65 to 1.95	–	3.9	7.8	–	8.2	
			2.3 to 2.7	–	2.8	5.4	–	5.8	
			3.0 to 3.6	–	2.3	4.4	–	4.6	
		C_L = 15 pF, R_L = 1 MΩ	0.9	–	38.4	–	–	–	
			1.1 to 1.3	–	9.9	25.1	–	41.6	
			1.4 to 1.6	–	5.6	11.5	–	12.6	
			1.65 to 1.95	–	4.1	8.4	–	8.7	
			2.3 to 2.7	–	2.9	5.7	–	6.1	
			3.0 to 3.6	–	2.4	4.6	–	5.0	
		C_L = 30 pF, R_L = 1 MΩ	0.9	–	39.6	–	–	–	
			1.1 to 1.3	–	10.5	35.7	–	58.1	
			1.4 to 1.6	–	6.0	15.8	–	17.6	
			1.65 to 1.95	–	4.7	10.7	–	11.7	
			2.3 to 2.7	–	3.2	6.9	–	8.1	
			3.0 to 3.6	–	2.6	5.2	–	6.1	

Table 5. CAPACITIVE CHARACTERISTICS

Symbol	Parameter	Test Condition	Typical (T_A = 25°C)	Unit
C_{IN}	Input Capacitance	V_{CC} = 0 V	3.0	pF
C_{OUT}	Output Capacitance	V_{CC} = 0 V	3.0	pF
C_{PD}	Power Dissipation Capacitance (Note 5)	f = 10 MHz, V_{CC} = 0.9 V to 3.6 V, V_{IN} = 0 V or V_{CC}	4.0	pF

5. C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the dynamic operating current consumption without load. Average operating current can be obtained by the equation $I_{CC(OPR)} = C_{PD} \cdot V_{CC} \cdot f_{in} + I_{CC}$. C_{PD} is used to determine the no–load dynamic power consumption: $P_D = C_{PD} \cdot V_{CC}^2 \cdot f_{in} + I_{CC} \cdot V_{CC}$.

NL17SG14

Test	Switch Position
t_{PLH} / t_{PHL}	Open
t_{PLZ} / t_{PZL}	$2 \times V_{CC}$
t_{PHZ} / t_{PZH}	GND

C_L includes probe and jig capacitance
R_T is Z_{OUT} of pulse generator (typically 50 W)
f = 1 MHz

Figure 5. Test Circuit
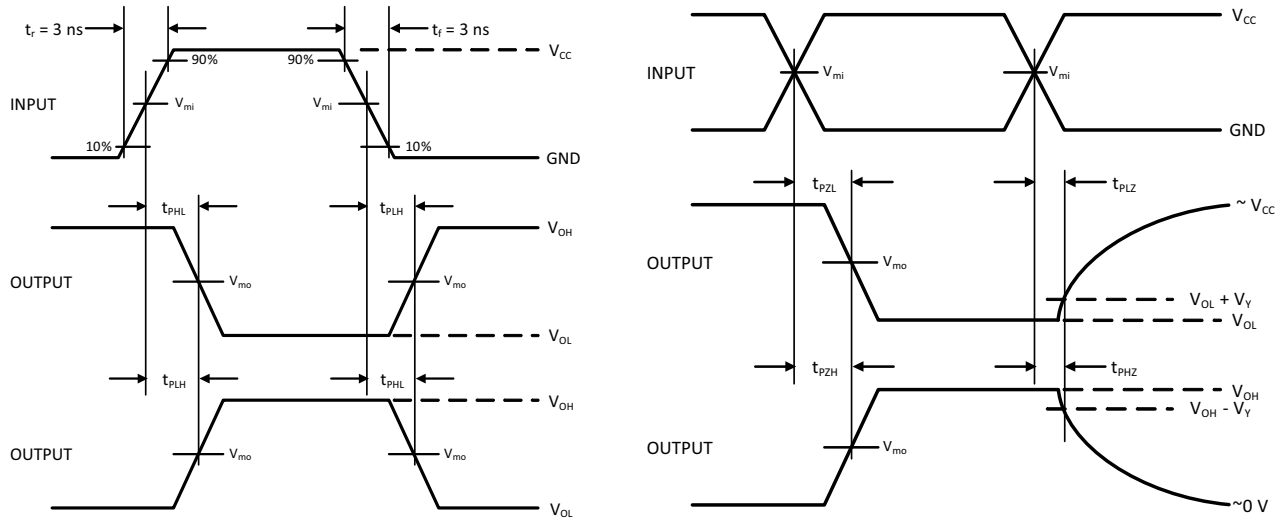
Figure 6. Switching Waveforms

V_{CC}, V	V_{mi}, V	V_{mo}, V	V_Y, V
0.9	$V_{CC}/2$	$V_{CC}/2$	0.1
1.1 to 1.3	$V_{CC}/2$	$V_{CC}/2$	0.1
1.4 to 1.6	$V_{CC}/2$	$V_{CC}/2$	0.1
1.65 to 1.95	$V_{CC}/2$	$V_{CC}/2$	0.15
2.3 to 2.7	$V_{CC}/2$	$V_{CC}/2$	0.15
3.0 to 3.6	1.5	1.5	0.3

NL17SG14

ORDERING INFORMATION

Device	Package	Marking	Pin 1 Orientation (See below)	Shipping†
NL17SG14MU1TCG	UDFN6, 1.45 x 1.0	4 (Rotated 180°CW)	Q4	3000 / Tape & Reel
NL17SG14DFT2G−Q*	SC−88A	AR	Q4	3000 / Tape & Reel
NL17SG14P5T5G	SOT−953	2	Q2	8000 / Tape & Reel

DISCONTINUED (Note 6)

NL17SG14DFT2G	SC−88A	AR	Q4	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

*−Q Suffix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC − Q100 Qualified and PPAP Capable.

6. **DISCONTINUED:** These devices are not recommended for new design. Please contact your **onsemi** representative for information. The most current information on these devices may be available on www.onsemi.com.

PIN 1 ORIENTATION IN TAPE AND REEL
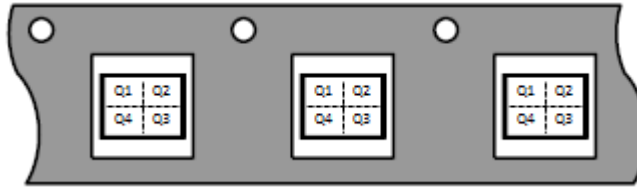
NL17SG14

PACKAGE DIMENSIONS

UDFN6, 1x1, 0.35P
CASE 517BX
ISSUE O
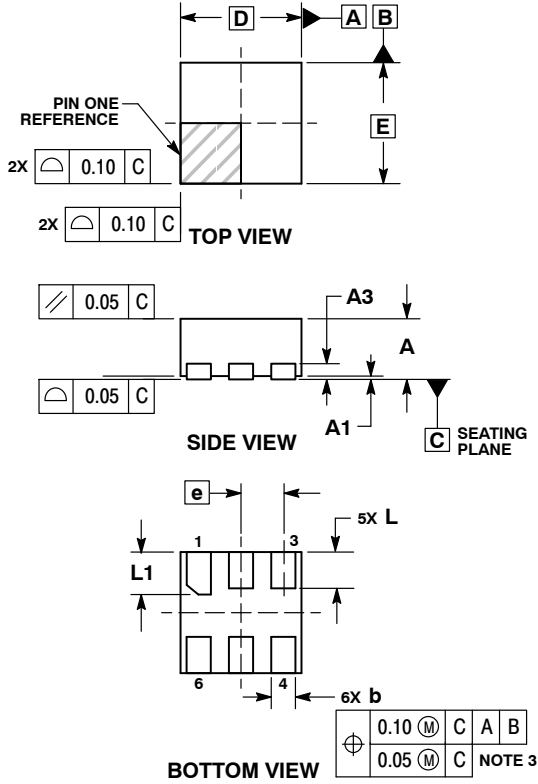
NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.20 MM FROM TERMINAL TIP.
4. PACKAGE DIMENSIONS EXCLUSIVE OF BURRS AND MOLD FLASH.

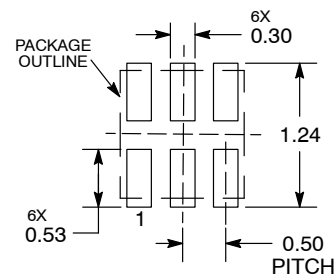| DIM	MILLIMETERS	
	MIN	MAX
A	0.45	0.55
A1	0.00	0.05
A3	0.13 REF	
b	0.12	0.22
D	1.00 BSC	
E	1.00 BSC	
e	0.35 BSC	
L	0.25	0.35
L1	0.30	0.40

TOP VIEW

2X ⌴ 0.10 C
2X ⌴ 0.10 C

PIN ONE REFERENCE

D A B
E

SIDE VIEW

⫽ 0.05 C
⌴ 0.05 C
A3
A
A1
C SEATING PLANE

BOTTOM VIEW

e
5X L
L1
1 3
6 4
6X b

⊕ | 0.10 Ⓜ C A B |
| 0.05 Ⓜ C | NOTE 3

RECOMMENDED SOLDERING FOOTPRINT*
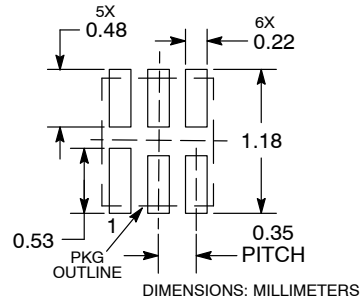
5X
0.48
6X
0.22
1.18
0.53
1
0.35
PITCH
PKG OUTLINE

DIMENSIONS: MILLIMETERS

*For additional information on our Pb–Free strategy and soldering details, please download the **onsemi** Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

SC−88A (SC−70−5/SOT−353)
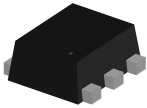CASE 419A−02
ISSUE M

DATE 11 APR 2023

SCALE 2:1

NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETERS
3. 419A−01 OBSOLETE. NEW STANDARD 419A−02
4. DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.1016MM PER SIDE.

5X b
$\oplus$ 0.2 Ⓜ B Ⓜ

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	0.80	0.95	1.10
A1	---	---	0.10
A3	0.20 REF		
b	0.10	0.20	0.30
c	0.10	---	0.25
D	1.80	2.00	2.20
E	2.00	2.10	2.20
E1	1.15	1.25	1.35
e	0.65 BSC		
L	0.10	0.15	0.30

RECOMMENDED
MOUNTING FOOTPRINT

0.50
0.65
0.40
0.65
1.90

* For additional information on our Pb−Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*

XXXM■

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

XXX = Specific Device Code
M = Date Code
■ = Pb−Free Package

(Note: Microdot may be in either location)

STYLE 1:
PIN 1. BASE
2. EMITTER
3. BASE
4. COLLECTOR
5. COLLECTOR

STYLE 2:
PIN 1. ANODE
2. EMITTER
3. BASE
4. COLLECTOR
5. CATHODE

STYLE 3:
PIN 1. ANODE 1
2. N/C
3. ANODE 2
4. CATHODE 2
5. CATHODE 1

STYLE 4:
PIN 1. SOURCE 1
2. DRAIN 1/2
3. SOURCE 1
4. GATE 1
5. GATE 2

STYLE 5:
PIN 1. CATHODE
2. COMMON ANODE
3. CATHODE 2
4. CATHODE 3
5. CATHODE 4

STYLE 6:
PIN 1. EMITTER 2
2. BASE 2
3. EMITTER 1
4. COLLECTOR
5. COLLECTOR 2/BASE 1

STYLE 7:
PIN 1. BASE
2. EMITTER
3. BASE
4. COLLECTOR
5. COLLECTOR

STYLE 8:
PIN 1. CATHODE
2. COLLECTOR
3. N/C
4. BASE
5. EMITTER

STYLE 9:
PIN 1. ANODE
2. CATHODE
3. ANODE
4. ANODE
5. ANODE

Note: Please refer to datasheet for style callout. If style type is not called out in the datasheet refer to the device datasheet pinout or pin assignment.

DOCUMENT NUMBER:	**98ASB42984B**		
DESCRIPTION:	**SC−88A (SC−70−5/SOT−353)**		**PAGE 1 OF 1**

onsemi™

UDFN6, 1.45x1.0, 0.5P
CASE 517AQ
ISSUE O

SCALE 4:1

DATE 15 MAY 2008

NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 mm FROM THE TERMINAL TIP.

TOP VIEW

PIN ONE REFERENCE

| 0.10 | C |

| 0.10 | C |
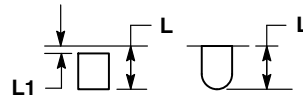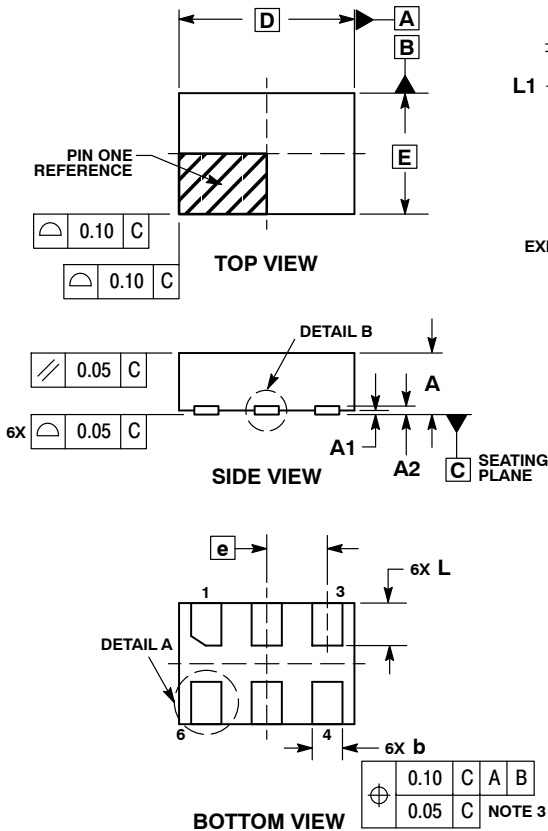
DETAIL A
OPTIONAL CONSTRUCTIONS

L
L
L1

EXPOSED Cu   MOLD CMPD
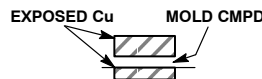
DETAIL B
OPTIONAL CONSTRUCTIONS

SIDE VIEW

| | 0.05 | C |
| 6X | 0.05 | C |

DETAIL B
A
A1
A2
C SEATING PLANE

DIM	MILLIMETERS	
	MIN	MAX
A	0.45	0.55
A1	0.00	0.05
A2	0.07 REF	
b	0.20	0.30
D	1.45 BSC	
E	1.00 BSC	
e	0.50 BSC	
L	0.30	0.40
L1	---	0.15

BOTTOM VIEW

e
6X L
DETAIL A
6X b

| ⊕ | 0.10 | C | A | B |
| | 0.05 | C | NOTE 3 |

MOUNTING FOOTPRINT

PACKAGE OUTLINE
6X 0.30
1.24
6X 0.53
1
0.50 PITCH

DIMENSIONS: MILLIMETERS

*For additional information on our Pb−Free strategy and soldering details, please download the **onsemi** Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*

XM

X = Specific Device Code
M = Date Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, "G" or microdot " ▪ ", may or may not be present.

DOCUMENT NUMBER:	98AON30313E	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.
DESCRIPTION:	UDFN6, 1.45x1.0, 0.5P	PAGE 1 OF 1

SOT−953 1.00x0.80x0.37, 0.35P
CASE 527AE
ISSUE F

DATE 17 JAN 2024

NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2018.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF THE BASE MATERIAL.
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

DIM	MIN	NOM	MAX
A	0.34	0.37	0.40
b	0.10	0.15	0.20
C	0.07	0.12	0.17
D	0.95	1.00	1.05
E	0.75	0.80	0.85
e	0.35 BSC		
H	0.95	1.00	1.05
L	0.125	0.175	0.225
L2	0.05	0.10	0.15
L3	0.075 (REF)		

MILLIMETERS
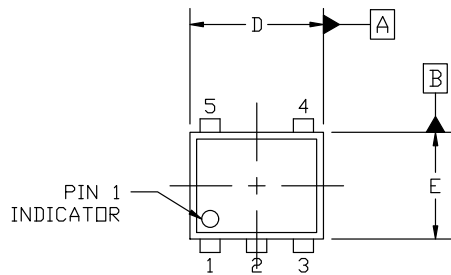
TOP VIEW
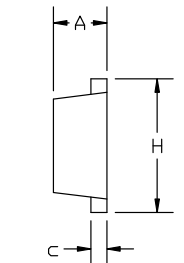
SIDE VIEW
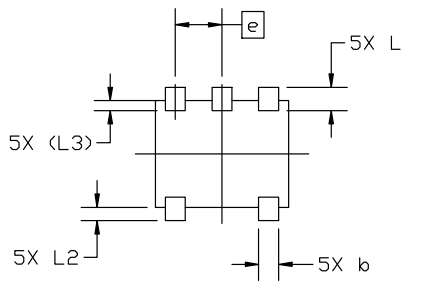
BOTTOM VIEW

⊕ 0.08 A B
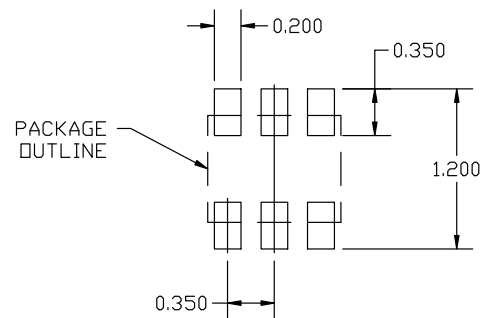
RECOMMENDED MOUNTING FOOTPRINT

PACKAGE OUTLINE

0.200
0.350
1.200
0.350

*For additional information on our Pb−Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*

XM
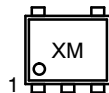
X = Specific Device Code
M = Month Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, "G" or microdot "▪", may or may not be present. Some products may not follow the Generic Marking.

DOCUMENT NUMBER:	98AON26457D	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION:	SOT−953 1.00x0.80x0.37, 0.35P		PAGE 1 OF 1

ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:
Technical Library: www.onsemi.com/design/resources/technical–documentation
onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support
For additional information, please contact your local Sales Representative at
www.onsemi.com/support/sales

◊